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Kind regards,

Team Nexperia



PBSS5160DS

60 V, 1 A PNP/PNP low V_{CEsat} (BISS) transistor Rev. 03 — 9 October 2008

Product data sheet

Product profile

1.1 General description

PNP/PNP low V_{CEsat} Breakthrough In Small Signal (BISS) transistor pair in a small SOT457 (SC-74) Surface-Mounted Device (SMD) plastic package.

NPN complement: PBSS4160DS.

1.2 Features

- Low collector-emitter saturation voltage V_{CEsat}
- High collector current capability I_C and I_{CM}
- High collector current gain (h_{FE}) at high I_C
- High efficiency due to less heat generation
- Smaller required Printed-Circuit Board (PCB) area than for conventional transistors

1.3 Applications

- Dual low power switches (e.g. motors, fans)
- Automotive applications

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V_{CEO}	collector-emitter voltage	open base		-	-	-60	V
I _C	collector current		[1]	-	-	-1	Α
I _{CM}	peak collector current	single pulse; $t_p \le 1 \text{ ms}$		-	-	-2	Α
R _{CEsat}	collector-emitter saturation resistance	$I_{C} = -1 A;$ $I_{B} = -100 \text{ mA}$	[2]	-	250	330	mΩ

^[1] Device mounted on a ceramic PCB, Al₂O₃, standard footprint.

[2] Pulse test: $t_p \le 300 \ \mu s$; $\delta \le 0.02$.



2. Pinning information

Table 2. Pinning

Table 2.	Filling		
Pin	Description	Simplified outline	Graphic symbol
1	emitter TR1		
2	base TR1	<u> </u>	6 5 4
3	collector TR2		TR2
4	emitter TR2	<u> 1 2 3</u>	(TR1)
5	base TR2		
6	collector TR1		1 2 3
			sym018

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
PBSS5160DS	SC-74	plastic surface-mounted package (TSOP6); 6 leads	SOT457

4. Marking

Table 4. Marking codes

Type number	Marking code
PBSS5160DS	A5

5. Limiting values

Table 5. Limiting values

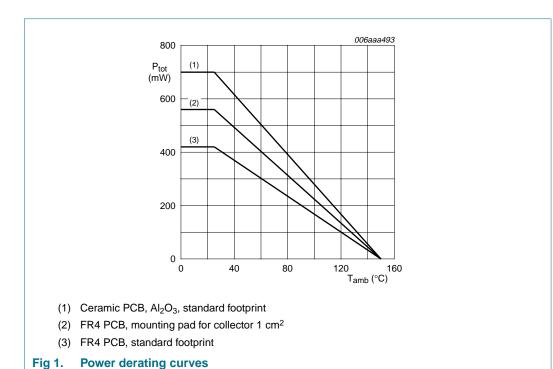
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
Per transi	istor				
V_{CBO}	collector-base voltage	open emitter	-	-80	V
V_{CEO}	collector-emitter voltage	open base	-	-60	V
V_{EBO}	emitter-base voltage	open collector	-	- 5	V
I _C	collector current		<u>[1]</u> -	-0.77	Α
			[2] _	-0.9	Α
			[3] _	–1	А
I _{CM}	peak collector current	single pulse; $t_p \le 1$ ms	-	-2	Α
I _B	base current		-	-300	mA
I _{BM}	peak base current	single pulse; t _p ≤ 1 ms	-	-1	Α

Table 5. Limiting values ...continued
In accordance with the Absolute Maximum Rating System (IEC 60134).

Parameter	Conditions	Min	Max	Unit
total power dissipation	$T_{amb} \le 25 ^{\circ}C$	<u>[1]</u> -	290	mW
		[2] -	370	mW
		[3] _	450	mW
е				
P _{tot} total power dissipation	$T_{amb} \le 25 ^{\circ}C$	<u>[1]</u> _	420	mW
		[2] -	560	mW
		[3] _	700	mW
junction temperature		-	150	°C
ambient temperature		-65	+150	°C
storage temperature		-65	+150	°C
	total power dissipation total power dissipation junction temperature ambient temperature	total power dissipation $T_{amb} \le 25~^{\circ}C$ e total power dissipation $T_{amb} \le 25~^{\circ}C$ junction temperature ambient temperature	total power dissipation $T_{amb} \le 25 ^{\circ}C$ $\begin{tabular}{c c} [1] & - & \\ \hline [2] & - & \\ \hline [3] & - & \\ \hline \end{tabular}$ total power dissipation $T_{amb} \le 25 ^{\circ}C$ $\begin{tabular}{c c} [1] & - & \\ \hline [2] & - & \\ \hline [2] & - & \\ \hline [3] & - & \\ \hline \end{tabular}$ junction temperature -65	$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1 cm².
- [3] Device mounted on a ceramic PCB, Al₂O₃, standard footprint.

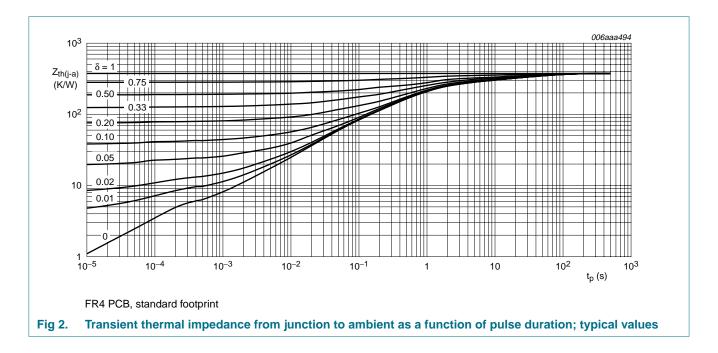


6. Thermal characteristics

Table 6. Thermal characteristics

Table 6.	Thermal characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Per trans	istor					
R _{th(j-a)} thermal resistance from junction to ambient	thermal resistance from	in free air	<u>[1]</u> _	-	431	K/W
	junction to ambient		[2] _	-	338	K/W
			[3]	-	278	K/W
$R_{th(j-sp)}$	thermal resistance from junction to solder point		-	-	105	K/W
Per devic	е					
R _{th(j-a)}	thermal resistance from	in free air	<u>[1]</u> _	-	298	K/W
	junction to ambient		[2] _	-	223	K/W
			[3]	-	179	K/W

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1 cm².
- [3] Device mounted on a ceramic PCB, Al₂O₃, standard footprint.



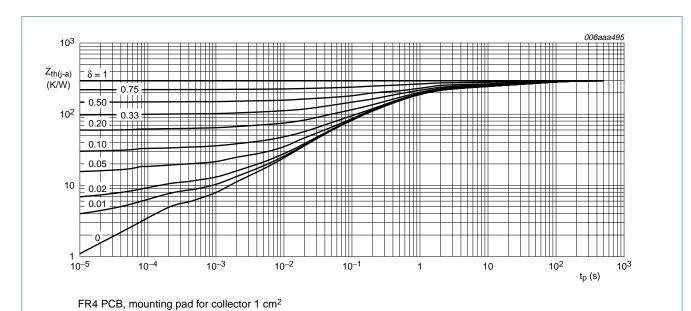


Fig 3. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

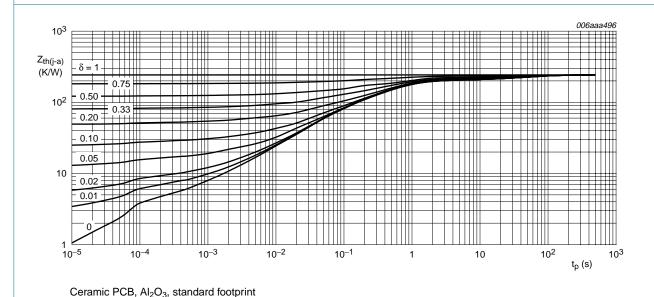


Fig 4. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

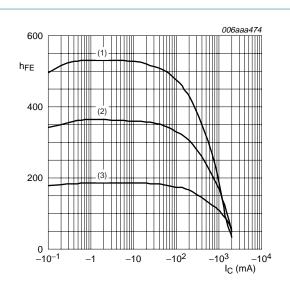
7. Characteristics

Table 7. Characteristics

 $T_{amb} = 25 \,^{\circ}C$ unless otherwise specified.

	C unless otherwise spec					
Symbol	Parameter	Conditions	Mi	in Typ	Max	Unit
Per transi	istor					
I_{CBO}	collector-base cut-off	$V_{CB} = -60 \text{ V}; I_E = 0 \text{ A}$	-	-	-100	nΑ
	current	$V_{CB} = -60 \text{ V}; I_E = 0 \text{ A};$ $T_j = 150 ^{\circ}\text{C}$	-	-	-50	μΑ
I _{CES}	collector-emitter cut-off current	$V_{CE} = -60 \text{ V}; V_{BE} = 0 \text{ V}$	-	-	-100	nA
I _{EBO}	emitter-base cut-off current	$V_{EB} = -5 \text{ V}; I_C = 0 \text{ A}$	-	-	-100	nA
h _{FE}	DC current gain	$V_{CE} = -5 \text{ V}; I_{C} = -1 \text{ mA}$	20	0 350	-	
		$V_{CE} = -5 \text{ V}; I_{C} = -500 \text{ mA}$	<u>[1]</u> 15	0 250	-	
		$V_{CE} = -5 \text{ V}; I_{C} = -1 \text{ A}$	<u>[1]</u> 10	0 160	-	
V _{CEsat} collector-emitter	$I_C = -100 \text{ mA}; I_B = -1 \text{ mA}$	-	-110	-165	mV	
	saturation voltage	$I_C = -500 \text{ mA}; I_B = -50 \text{ mA}$	-	-120	-175	mV
		$I_C = -1 A$; $I_B = -100 \text{ mA}$	[1] -	-250	-330	mV
V_{BEsat}	base-emitter saturation voltage	$I_C = -1 A$; $I_B = -50 \text{ mA}$	[1] -	-0.95	5 –1.1	V
R _{CEsat}	collector-emitter saturation resistance	$I_C = -1 A$; $I_B = -100 \text{ mA}$	[1] -	250	330	mΩ
V_{BEon}	base-emitter turn-on voltage	$I_C = -1 A$; $V_{CE} = -5 V$	[1] -	-0.82	2 –0.9	V
t _d	delay time	$I_C = -0.5 \text{ A}$; $I_{Bon} = -25 \text{ mA}$;	-	11	-	ns
t _r	rise time	$I_{Boff} = 25 \text{ mA}$	-	30	-	ns
t _{on}	turn-on time		-	41	-	ns
ts	storage time		-	205	-	ns
t _f	fall time		-	55	-	ns
t _{off}	turn-off time		-	260	-	ns
f _T	transition frequency	$V_{CE} = -10 \text{ V}; I_{C} = -50 \text{ mA};$ f = 100 MHz	15	0 185	-	MHz
C _c	collector capacitance	$V_{CB} = -10 \text{ V}; I_E = i_e = 0 \text{ A};$ f = 1 MHz	-	9	15	pF

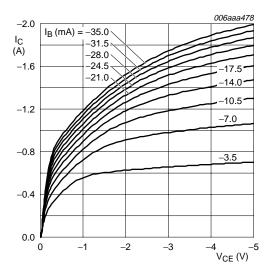
^[1] Pulse test: $t_p \le 300~\mu s;~\delta \le 0.02.$



$$V_{CE} = -5 \text{ V}$$

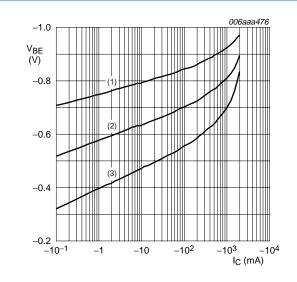
- (1) $T_{amb} = 100 \, ^{\circ}C$
- (2) $T_{amb} = 25 \, ^{\circ}C$
- (3) $T_{amb} = -55 \,^{\circ}C$

Fig 5. DC current gain as a function of collector current; typical values



T_{amb} = 25 °C

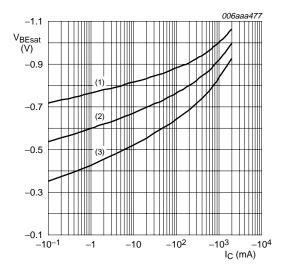
Fig 6. Collector current as a function of collector-emitter voltage; typical values





- (1) $T_{amb} = -55 \,^{\circ}C$
- (2) $T_{amb} = 25 \, ^{\circ}C$
- (3) $T_{amb} = 100 \, ^{\circ}C$

Fig 7. Base-emitter voltage as a function of collector current; typical values

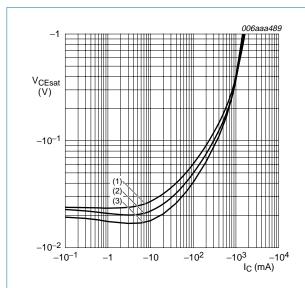


 $I_{\rm C}/I_{\rm B} = 20$

- (1) $T_{amb} = -55 \,^{\circ}C$
- (2) $T_{amb} = 25 \,^{\circ}C$
- (3) $T_{amb} = 100 \, ^{\circ}C$

Fig 8. Base-emitter saturation voltage as a function of collector current; typical values

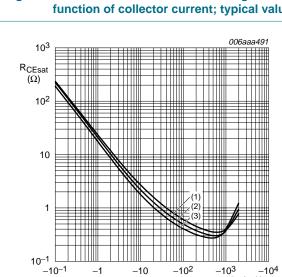
PBSS5160DS_3 © NXP B.V. 2008. All rights reserved.



$$I_{\rm C}/I_{\rm B} = 20$$

- (1) $T_{amb} = 100 \, ^{\circ}C$
- (2) $T_{amb} = 25 \, ^{\circ}C$
- (3) $T_{amb} = -55 \, ^{\circ}C$

Collector-emitter saturation voltage as a Fig 9. function of collector current; typical values

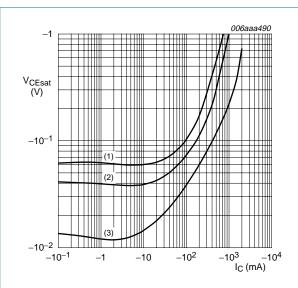


$$I_{\rm C}/I_{\rm B} = 20$$

- (1) $T_{amb} = 100 \, ^{\circ}C$
- (2) $T_{amb} = 25 \, ^{\circ}C$
- (3) $T_{amb} = -55 \,^{\circ}C$

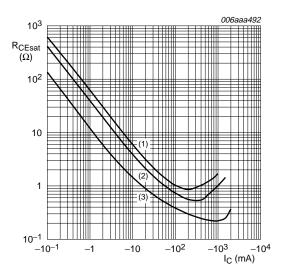
Fig 11. Collector-emitter saturation resistance as a function of collector current; typical values

I_C (mA)



- (1) $I_C/I_B = 100$
- (2) $I_C/I_B = 50$
- (3) $I_C/I_B = 10$

Fig 10. Collector-emitter saturation voltage as a function of collector current; typical values



- (1) $I_C/I_B = 100$
- (2) $I_C/I_B = 50$
- (3) $I_C/I_B = 10$

Fig 12. Collector-emitter saturation resistance as a function of collector current; typical values

8. Test information

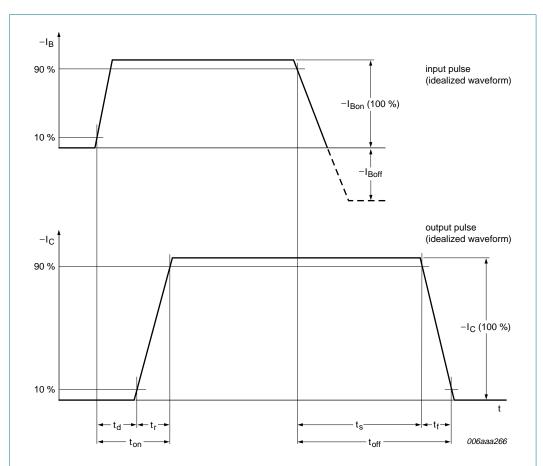
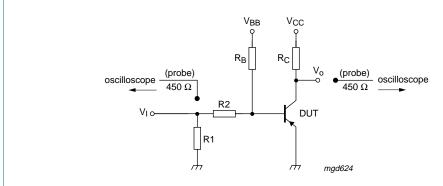


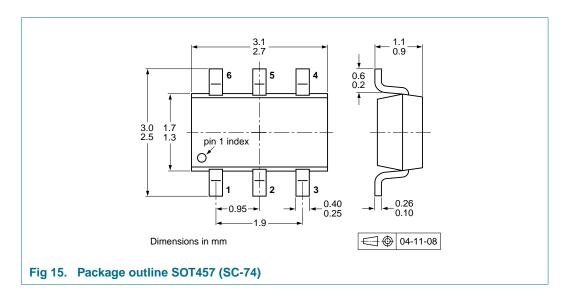
Fig 13. BISS transistor switching time definition



 I_C = -0.5 A; I_{Bon} = -25 mA; I_{Boff} = 25 mA; R1 = open; R2 = 100 Ω ; R_B = 300 Ω ; R_C = 20 Ω

Fig 14. Test circuit for switching times

9. Package outline



10. Packing information

Table 8. Packing methods

The indicated -xxx are the last three digits of the 12NC ordering code.[1]

Type number	Package	Description		Packing quantity	
				3000	10000
PBSS5160DS	SOT457	4 mm pitch, 8 mm tape and reel; T1	[2]	-115	-135
		4 mm pitch, 8 mm tape and reel; T2	<u>[3]</u>	-125	-165

[1] For further information and the availability of packing methods, see $\underline{\text{Section 14}}$.

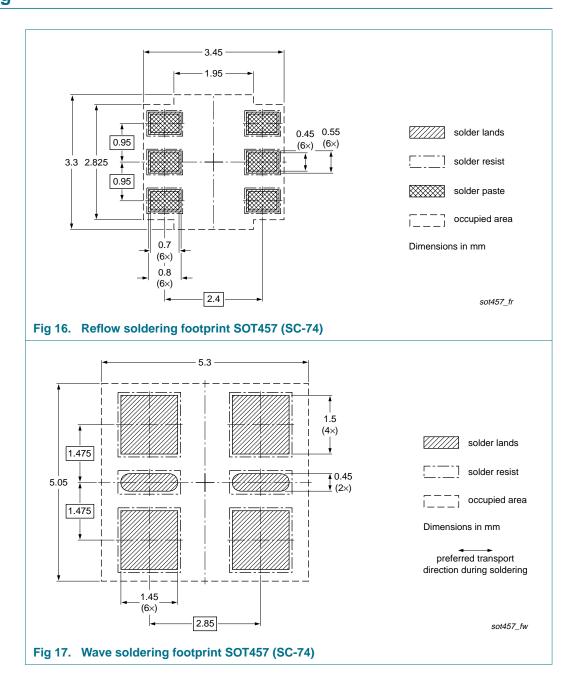
[2] T1: normal taping

[3] T2: reverse taping

11 of 14

60 V, 1 A PNP/PNP low V_{CEsat} (BISS) transistor

11. Soldering



12. Revision history

Table 9. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PBSS5160DS_3	20081009	Product data sheet	-	PBSS5160DS_2
Modifications:	guidelines o	of this data sheet has been of NXP Semiconductors.		•
	 Legal texts 	have been adapted to the n	ew company name whe	ere appropriate.
	Figure 9: ar	mended		
	• Section 13	"Legal information": updated	t	
PBSS5160DS_2	20050628	Product data sheet	-	PBSS5160DS_1
PBSS5160DS_1	20040716	Objective data sheet	-	-

13. Legal information

13.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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- [2] The term 'short data sheet' is explained in section "Definitions"
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15. Contents

1	Product profile
1.1	General description
1.2	Features
1.3	Applications
1.4	Quick reference data
2	Pinning information 2
3	Ordering information 2
4	Marking 2
5	Limiting values
6	Thermal characteristics 4
7	Characteristics 6
8	Test information 9
9	Package outline
10	Packing information
11	Soldering 11
12	Revision history
13	Legal information
13.1	Data sheet status
13.2	Definitions
13.3	Disclaimers
13.4	Trademarks13
14	Contact information
15	Contents 14

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